

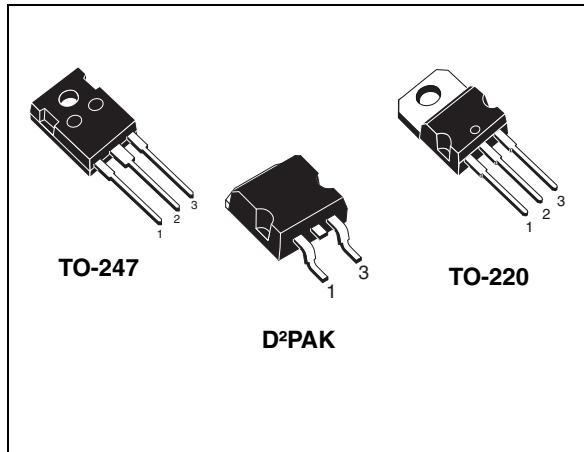
# STP30NF20 - STB30NF20 STW30NF20

**N-channel 200V - 0.065Ω - 30A - TO-220/TO-247/D<sup>2</sup>PAK  
Low gate charge STripFET™ Power MOSFET**

## Features

Type	V <sub>DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>	P <sub>TOT</sub>
STP30NF20	200V	0.075Ω	30A	125W
STW30NF20	200V	0.075Ω	30A	125W
STB30NF20	200V	0.075Ω	30A	125W

- Gate charge minimized
- 100% avalanche tested
- Excellent figure of merit (R<sub>DS</sub>\*Q<sub>g</sub>)
- Very good manufacturing repeatability
- Very low intrinsic capacitances



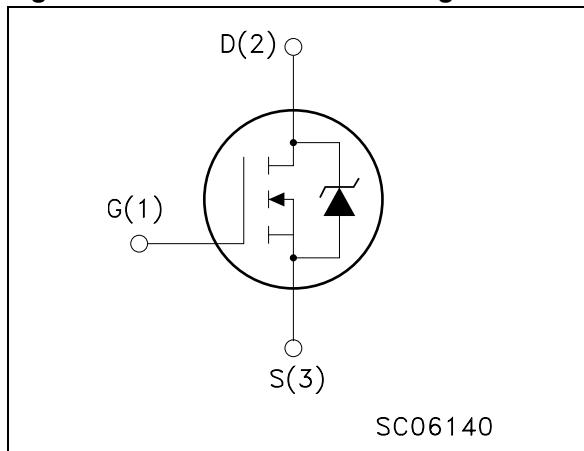
## Application

- Switching applications

## Description

This Power MOSFET series realized with STMicroelectronics unique STripFET process has specifically been designed to minimize input capacitance and gate charge. It is therefore suitable as primary switch in advanced high-efficiency isolated DC-DC converters.

**Figure 1. Internal schematic diagram**



**Table 1. Device summary**

Order codes	Marking	Package	Packaging
STP30NF20	30NF20	TO-220	Tube
STW30NF20	30NF20	TO-247	Tube
STB30NF20	30NF20	D <sup>2</sup> PAK	Tape & reel

# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage ( $V_{GS} = 0$ )	200	V
$V_{GS}$	Gate-source voltage	$\pm 20$	V
$I_D$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	30	A
$I_D$	Drain current (continuous) at $T_C = 100^\circ\text{C}$	19	A
$I_{DM}^{(1)}$	Drain current (pulsed)	120	A
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	125	W
	Derating factor	1	W/ $^\circ\text{C}$
$dv/dt^{(2)}$	Peak diode recovery voltage slope	10	V/ns
$T_J$ $T_{stg}$	Operating junction temperature Storage temperature	-55 to 150	$^\circ\text{C}$
$T_I$	Maximum lead temperature for soldering purpose	300	$^\circ\text{C}$

1. Pulse width limited by safe operating area
2.  $I_{SD} \leq 30\text{A}$ ,  $di/dt \leq 200\text{A}/\mu\text{s}$ ,  $V_{DD} = 80\%V_{(\text{BR})DSS}$

**Table 3. Thermal data**

Symbol	Parameter	TO-220/ D <sup>2</sup> PAK	TO-247	Unit
$R_{thJC}$	Thermal resistance junction-case max	1		$^\circ\text{C}/\text{W}$
$R_{thJA}$	Thermal resistance junction-ambient max	62.5	50	$^\circ\text{C}/\text{W}$

**Table 4. Avalanche data**

Symbol	Parameter	Value	Unit
$I_{AR}$	Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax}$ )	30	A
$E_{AS}$	Single pulse avalanche energy (starting $T_j = 25^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50\text{V}$ )	140	mJ

## 2 Electrical characteristics

( $T_{CASE}=25^\circ\text{C}$  unless otherwise specified)

**Table 5. On/off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 1\text{mA}$ , $V_{GS} = 0$	200			V
$I_{DSS}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = \text{Max rating}$ , $V_{DS} = \text{Max rating}, T_c=125^\circ\text{C}$			1 10	$\mu\text{A}$ $\mu\text{A}$
$I_{GSS}$	Gate body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 20\text{V}$			$\pm 100$	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250\mu\text{A}$	2	3	4	V
$R_{DS(\text{on})}$	Static drain-source on resistance	$V_{GS} = 10\text{V}$ , $I_D = 15\text{A}$		0.065	0.075	$\Omega$

**Table 6. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$g_{fs}^{(1)}$	Forward transconductance	$V_{DS} = 15\text{V}$ , $I_D = 15\text{A}$		20		S
$C_{iss}$ $C_{oss}$ $C_{rss}$	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25\text{V}$ , $f = 1\text{ MHz}$ , $V_{GS} = 0$		1597 320 43		pF pF pF
$Q_g$ $Q_{gs}$ $Q_{gd}$	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 160\text{V}$ , $I_D = 30\text{A}$ $V_{GS} = 10\text{V}$		38 8 18		nC nC nC

1. Pulsed: pulse duration=300μs, duty cycle 1.5%

**Table 7. Switching times**

<b>Symbol</b>	<b>Parameter</b>	<b>Test conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
$t_{d(on)}$ $t_r$	Turn-on delay time Rise time	$V_{DD}=100V$ , $I_D=15A$ , $R_G=4.7\Omega$ , $V_{GS}=10V$		35 15.7		ns ns
$t_{d(off)}$ $t_f$	Turn-off delay time Fall time	$V_{DD}=100V$ , $I_D=15A$ , $R_G=4.7\Omega$ , $V_{GS}=10V$		38 8.8		ns ns

**Table 8. Source drain diode**

<b>Symbol</b>	<b>Parameter</b>	<b>Test conditions</b>	<b>Min.</b>	<b>Typ.</b>	<b>Max.</b>	<b>Unit</b>
$I_{SD}$ $I_{SDM}^{(1)}$	Source-drain current Source-drain current (pulsed)				30 120	A A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD}=30A$ , $V_{GS}=0$			1.5	V
$t_{rr}$ $Q_{rr}$ $I_{RRM}$	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD}=30A$ , $di/dt = 100A/\mu s$ , $V_{DD}=100 V$ , $T_j=25^\circ C$		155 0.96 12.4		ns $\mu C$ A
$t_{rr}$ $Q_{rr}$ $I_{RRM}$	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD}=30A$ , $di/dt = 100A/\mu s$ , $V_{DD}=100 V$ , $T_j=150^\circ C$		194 1.42 14.6		ns $\mu C$ A

1. Pulse width limited by safe operating area

2. Pulsed: pulse duration=300 $\mu s$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-247

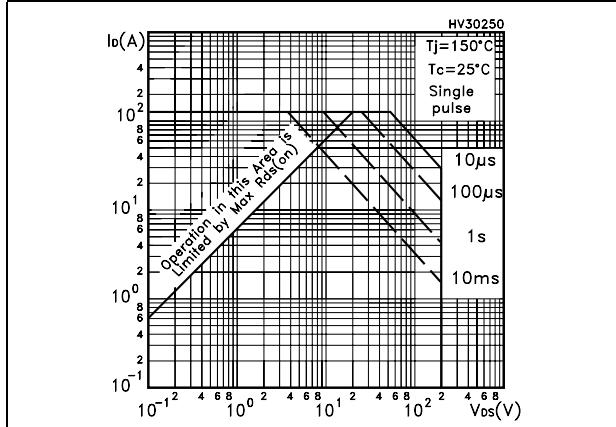


Figure 3. Thermal impedance for TO-247

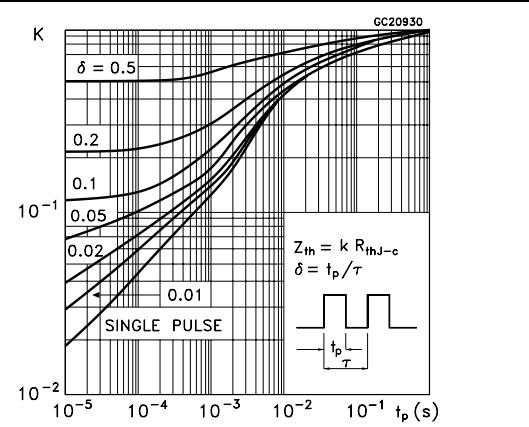
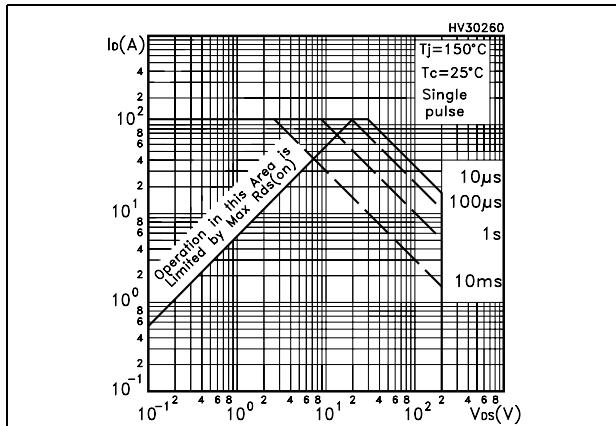
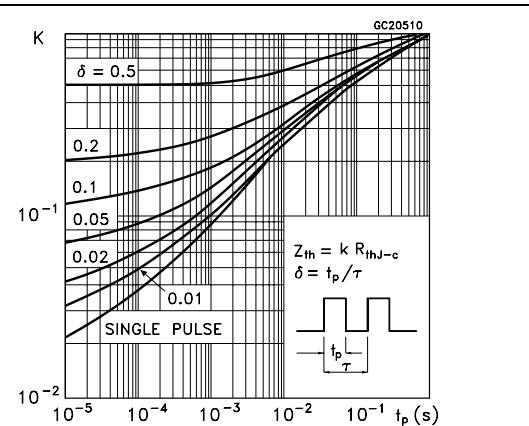
Figure 4. Safe operating area for TO-220/D<sup>2</sup>PAKFigure 5. Thermal impedance for TO-220/D<sup>2</sup>PAK

Figure 6. Output characteristics

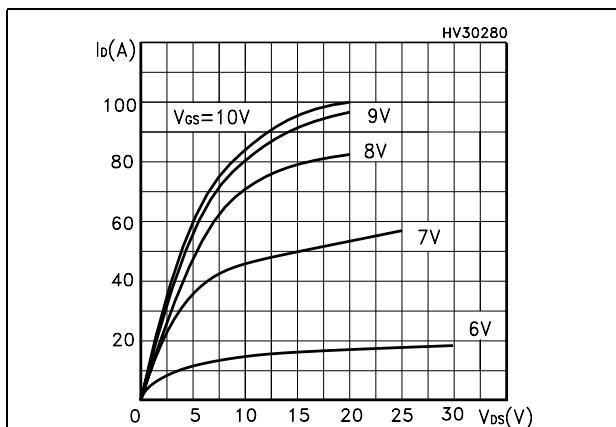


Figure 7. Transfer characteristics

